

ATTY. DOCKET NO.  
111150-021.USSERIAL NO.  
10/575,546APPLICANT:  
Oleg Y. Abramov et al.FILING DATE:  
April 10, 2006GROUP:  
To be assigned

JUL 13 2006

(Use several sheets if necessary)

U.S. PATENT DOCUMENTS					
Examiner Initials	Cite No.	Document Number	Publication Date/ Issue Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number-Kind Code			
/TN/	AA	6,473,036 B2	10-29-2002	Proctor Jr	
/TN/	AB	5,873,048 A	02-16-1999	Yun	
/TN/	AC	5,303,240	04-12-1994	Bonnes et al.	

## FOREIGN PATENT DOCUMENTS

Examiner Initials	Cite No.	Foreign Patent Document	Publication Date/Issue Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T <sup>1</sup>
/TN/	AD	RU 2207724 C1	06-27-2003	Algoritm		
/TN/	AE	WO 2001/005058	01-18-2001	Alcatel		
/TN/	AF	EP 1069706 A1	01-17-2001	Texas Instruments		

## NON PATENT LITERATURE DOCUMENTS

Examiner Initials	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T <sup>1</sup>

EXAMINER: /Tuan Nguyen/

DATE CONSIDERED: 09/11/2009

EXAMINER: Please initial if reference is considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include a copy of this form with next communication to applicant. Thank you.

'Applicant is to place a check mark here if English language translation is attached.